

AMENDMENTS TO THE SPECIFICATION

Please amend the paragraph on page 1 after the heading “CROSS-REFERENCE TO RELATED APPLICATIONS” of the specification as follows:

The current application is a continuation application of United States Application Serial No. 09/697,498, filed October 27, 2000 and titled *A Method for Testing a Light-Emitting Panel and the Components Therein*. The following applications filed on the same date as the present application are herein incorporated by reference: United States Patent Application No. 09/697,346 entitled *A Socket for Use with a Micro-Component in a Light-Emitting Panel* filed October 27, 2000, (~~Attorney Docket Number 203692~~); United States Patent Application No. 09/697,358 entitled *A Micro-Component for Use in a Light-Emitting Panel* filed October 27, 2000 (~~Attorney Docket Number 203690~~); United States Patent Application No. 09/697,345 entitled *A Method and System for Energizing a Micro-Component In a Light-Emitting Panel* filed October 27, 2000 (~~Attorney Docket Number 203688~~); and United States Patent Application No. 09/697,344 entitled *A Light-Emitting Panel and a Method of Making* filed October 27, 2000 (~~Attorney Docket Number 203694~~).

Please amend the paragraph beginning on page 26, line 20 of the specifications as follows:

During the panel dicing process ~~960~~ 950, the first and second “sandwiched” substrates are diced to form an individual light-emitting panel. After the dicing process ~~960~~ 950, inline testing is performed on the individual light-emitting panel. The characteristics of the individual light-emitting panel that may be tested include, but are not limited to, size, shape, and

luminosity. The luminosity, in both visible and non-visible regions, of the light-emitting display may be tested by pixel by pixel image analysis.